ABSOLUTE MAXIMUM RATINGS

Supply Voltage (V _{DD} to V _{SS})(V _{SS} - 0.3V) to +6V Voltage Inputs (AIN_, CIN_)(V _{SS} - 0.3V) to (V _{DD} + 0.3V) Output Short-Circuit Duration (AOUT, COUT, REF)Continuous	10-Pin µMAX (derate 5.6mW/°C above +70°C)444mW 14-Pin SO (derate 8.3mW/°C above +70°C)667mW Operating Temperature Range
to either V _{SS} or V _{DD} Continuous Power Dissipation (T _A = +70°C) 8-Pin SO (derate 5.88mW/°C above +70°C)471mW 8-Pin µMAX (derate 4.1mW/°C above +70°C)330mW	MAX900_E40°C to +85°C Maximum Junction Temperature+150°C Storage Temperature Range65°C to +160°C Lead Temperature (soldering, 10sec)+300°C

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ELECTRICAL CHARACTERISTICS

 $\text{(VDD = +2.5V to +5.5V, V}_{SS} = 0, \overline{SHDN} = V_{DD} \text{ (MAX9001/MAX9004 only), V}_{CM(OP AMP)} = 0, V_{AOUT} = V_{DD} / 2, V_{CM(COMP)} = 0 \text{ (for MAX9001/MAX9002/MAX9004/MAX9005), COUT} = \text{low, I}_{OUT(REF)} = 0, T_{A} = T_{MIN} \text{ to T}_{MAX}, \text{ unless otherwise noted. Typical values are at V}_{DD} = 5V \text{ and T}_{A} = +25^{\circ}\text{C.})$

PARAMETER	SYMBOL	CONDITIONS		MIN	TYP	MAX	UNITS
Supply Voltage Range	V _{DD}	Guaranteed by PSRR tests		2.5		5.5	V
Company Company		MAX9000/MAX9001/ MAX9003/MAX9004			410 450	500 550	μΑ
Supply Current	IDD	MAX9002/MAX9005	$V_{DD} = 3V$ $V_{DD} = 5V$		340 375	425 475	μΑ
Supply Current in Shutdown	ISHDN	MAX9001/MAX9004 (V _{SHDN} = 0)			2	5	μΑ
Shutdown Input Bias Current	lin(SHDN)	MAX9001/MAX9004 (V SHDN = 0 to V	DD)		1	2.5	μΑ
Shutdown Logic High	VIH(SHDN)			0.7 x VD[)		V
Shutdown Logic Low	VIL(SHDN)					0.3 x V _{DD}	V
OP AMP				•			
Input Offset Voltage	Vos	MAX900_ES_			±0.5	±1.5	mV
Input Offset Voltage Temperature Coefficient	TCV _{OS}	MAX900_ES_		±1		μV/°C	
Input Bias Current	IBIAS	AIN+, AIN-			±0.05	±2	nA
Input Offset Current		AIN+, AIN-			±0.02	±1	nA
Input Resistance	RIN	Differential or common mode			1000		MΩ
Input Common-Mode Voltage Range	CMVR	Guaranteed by CMRR test		-0.15		V _{DD} - 1.2	V
Common-Mode Rejection Ratio	CMRR	MAX900_ES_, $(V_{SS} - 0.15V) \le V_{CM} \le V_{DD} = 5.5V$	72	96		dB	
Power-Supply Rejection Ratio	PSRR	V _{DD} = 2.5V to 5.5V		74	100		dB
Output Resistance		$A_V = 1V/V$			0.01		Ω
Output Short-Circuit		Shorted to V _{SS} Shorted to V _{DD}			10		mA
Current					65		111/4
Disabled Mode Output Leakage	lout (DISABLED)	$V_{\overline{SHDN}} \le (0.3 \text{V x V}_{DD}), V_{AOUT} = 0 \text{ to V}_{DD}$			±0.01	±1	μΑ

ELECTRICAL CHARACTERISTICS (continued)

 $(V_{DD} = +2.5 \text{V to } +5.5 \text{V}, \text{ V}_{SS} = 0, \overline{\text{SHDN}} = \text{V}_{DD} \text{ (MAX9001/MAX9004 only)}, \text{ V}_{CM(OP \text{ AMP})} = 0, \text{ V}_{AOUT} = \text{V}_{DD} \text{ / 2}, \text{ V}_{CM(COMP)} = 0 \text{ (for MAX9001/MAX9002/MAX9004/MAX9005)}, \text{ COUT} = \text{low, I}_{OUT(REF)} = 0, \text{ T}_{A} = \text{T}_{MIN} \text{ to T}_{MAX}, \text{ unless otherwise noted. Typical values are at V}_{DD} = 5 \text{V} \text{ and T}_{A} = +25 ^{\circ}\text{C.})$

PARAMETER	SYMBOL	CONDITIONS		MIN	TYP	MAX	UNITS			
		$V_{AOUT} = 0.05V \text{ to } 2.45V, R_L = 100k\Omega$				94	125			
Large-Signal Voltage Gain		$V_{DD} = 2.5V$	VAOUT = 0.	84	115		40			
	Avol	.,	V _{AOUT} = 0.	05V to 5.4V, F	$R_L = 100k\Omega$	94	120		- dB -	
		$V_{DD} = 5.5V$	V _{AOUT} = 0.	25V to 5.2V, F	$R_L = 1k\Omega$	86	106			
				D 1001.0	VDD - VOH		1	1 5	mV	
	., ,,,	k, v	l> 10)/	$R_L = 100k\Omega$	VoL		1	5		
Output Voltage Swing	Vol / Voh	V _{AIN+} - V _{AI}	IN- IS 10MV	D 41.0	V _{DD} - V _{OH}		140	250		
		$R_L = 1k\Omega$ V_{OL}		VoL		60	100	-		
0 0 1 1 1 1 1 1 1 1	0.0044	MAX9000/MAX9001/l		X9002			1.25			
Gain-Bandwidth Product	GBW	MAX9003/N	//AX9004/MA	X9005			8		MHz	
		MAX9000/N	/AX9001/MA	X9002			75		degrees	
Phase Margin		MAX9003/N	/AX9004/MA	X9005			80			
		MAX9000/N	//AX9001/MA	X9002			30		 	
Gain Margin		MAX9003/N	/AX9004/MA	X9005			40		- dB	
Total Harmonic Distortion	TUE	f = 10kHz, MAX9000/MAX MAX9002 (A _V =				0.009		%		
plus Noise	THD+N	VAOUT = 2Vp-p, VDD = 5V			0.028					
01 5 1	SR	V _{DD} = 5V,	V _{DD} = 5V,		MAX9001/ A _V = 1V/V)		0.85		\//a	
Slew Rate	SK	VAOUT = 4V	/ step		MAX9003/MAX9004/ MAX9005 (A _V = 10V/V)		6.0		- V/µs	
Sottling Time to within 0.010/		V _{DD} = 5V,	V _{DD} = 5V,		MAX9001/ A _V = 1V/V)		6.9	lue.		
Settling Time to within 0.01%		VAOUT = 4V	/ step	MAX9003/N MAX9005 (MAX9004/ Av = 10V/V)		2.1		μs	
Input Capacitance	CIN						2.5		pF	
Input Noise Voltage Density	VNOISE	f = 10kHz			36		nV/√Hz			
Input Noise Current Density	INOISE	f = 10kHz					1		fA/√Hz	
Shutdown Delay Time							0.2		μs	
Enable Delay Time							2		μs	
Power-On Time						2		μs		
Capacitive-Load Stability	CLOAD	MAX9000/MAX9001/MAX9002 (A _V = 1V/V) MAX9003/MAX9004/MAX9005 (A _V = 10V/V)			250 250		- pF			
COMPARATOR		1417 0 7 7 0 0 0 7 1 1		,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,	10 1/11/		200			
Input Offset Voltage	Vos	MAX900 F	S (Notes 1	2)			±1	±2	mV	
Input Offset Voltage Temperature Coefficient	TCVos	MAX900_ES_ (Notes 1, 2) MAX900_ES_				±1		μV/°C		
Input-Referred Hysteresis		V _{DD} = 5V (N	V _{DD} = 5V (Notes 2, 3)				4	7	mV	
<u> </u>	1	55 (1	



ELECTRICAL CHARACTERISTICS (continued)

(VDD = +2.5V to +5.5V, VSS = 0, SHDN = VDD (MAX9001/MAX9004 only), VCM(OP AMP) = 0, VAOUT = VDD / 2, VCM(COMP) = 0 (for MAX9001/MAX9002/MAX9004/MAX9005), COUT = low, I_{OUT(REF)} = 0, T_A = T_{MIN} to T_{MAX}, unless otherwise noted. Typical values are at $V_{DD} = 5V$ and $T_A = +25$ °C.)

PARAMETER	SYMBOL	CONDITIONS		MIN	TYP	MAX	UNITS		
Input Bias Current	I _{BIAS}				8	80	nA		
Input Offset Current	los	MAX9001/MAX9002/MAX9004/MAX9005				±2	±15	nA	
Common-Mode Voltage Range	Vсм	Guaranteed by	CMRR te	st		V _{SS} - 0.15		V _{DD} - 1.1	V
Common-Mode Rejection Ratio	CMRR	MAX9001/MAX 0.15V ≤ V _{CM} ≤			,	72	100		dB
Power-Supply Rejection Ratio	PSRR	V _{DD} = 2.5V to 5	V _{DD} = 2.5V to 5.5V			72	100		dB
Output Voltage Swing	Vol/Voh	(V _{CIN+} - V _{CIN-}) ≥ 20mV	V _{DD} - V _O	DН	ISOURCE = 10µA ISOURCE = 4mA ISINK = 10µA ISINK = 4mA	5 400		5 400	mV
Output Short-Circuit Current			1				55		mA
Disabled Mode Output Leakage	lout (DISABLED)	V SHDN ≤ (0.3V	VSHDN ≤ (0.3V x VDD), VCOUT = 0 to VDD				±0.01	±1	μΑ
Propagation Delay	tpD+, tpD-	$V_{OD} = 25$ mV, $R_L = 10$ k Ω , $C_L = 15$ pF (Note 4)				185		ns	
Rise/Fall Time	t _R , t _F	$V_{DD} = 5V, R_L =$	$V_{DD} = 5V$, $R_L = 10k\Omega$, $C_L = 15pF$ (Note 5)				10		ns
Shutdown Delay Time							100		ns
Enable Delay Time					100		ns		
Power-On Time					100		ns		
VOLTAGE REFERENCE (MAX9000/MA	X9001/MAX9003	MAX900	4)					
Output Voltage	V _{REF}	MAX900_ES_, V _{DD} = 5V, T _A = +25°C			1.218	1.230	1.242	V	
Output Voltage Temperature Coefficient	TCV _{REF}						8		ppm/°C
Line Regulation		$V_{DD} = 2.5V \text{ to } 5$	5.5V				20	250	μV/V
Load Regulation		$V_{DD} = 5V$,		Sour	cing		0.15	0.8	mV/mA
Load Regulation		$I_{OUT} = 0$ to 1m.	Α	Sink	ing		0.6	2.0	mV/mA
Output Short-Circuit		Shorted to V _{SS}				6		mA	
Current		Shorted to V _{DD}			10		IIIA		
Disabled Mode Output Leakage		$V_{\overline{SHDN}} \le (0.3V \times V_{DD}), V_{REF} = 0 \text{ to } V_{DD}$			±0.01	±1	μΑ		
Output Noise		0.1Hz to 10Hz				20		µVp-р	
Shutdown Delay Time							1		μs
Enable Delay Time		$R_L = 100k\Omega$ to Vss, VREF within 1%			1%		16		μs
Power-On Time		$R_L = 100k\Omega$ to Vss, VREF within 1%				16		μs	
Capacitive Load Stability						0 to 100		nF	

Note 1: Comparator Input Offset is defined as the center of the input-referred hysteresis zone.

Note 2: Measured at V_{CM}(COMP) = 0 for the MAX9001/MAX9002/MAX9005; or V_{CM}(COMP) = V_{REF} for the MAX9000/MAX9003.

Note 3: Input-referred hysteresis is defined as the difference of the trip points required to change comparator output states.

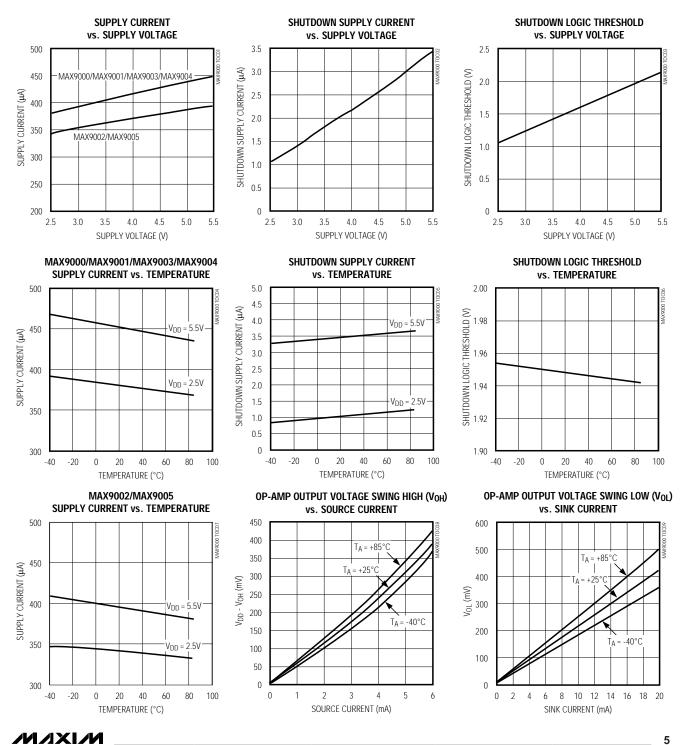
Note 4: V_{OD} is the overdrive that is beyond the offset and hysteresis-determined trip points.

Note 5: Rise and fall times are measured between 10% and 90% at COUT.

MIXIM

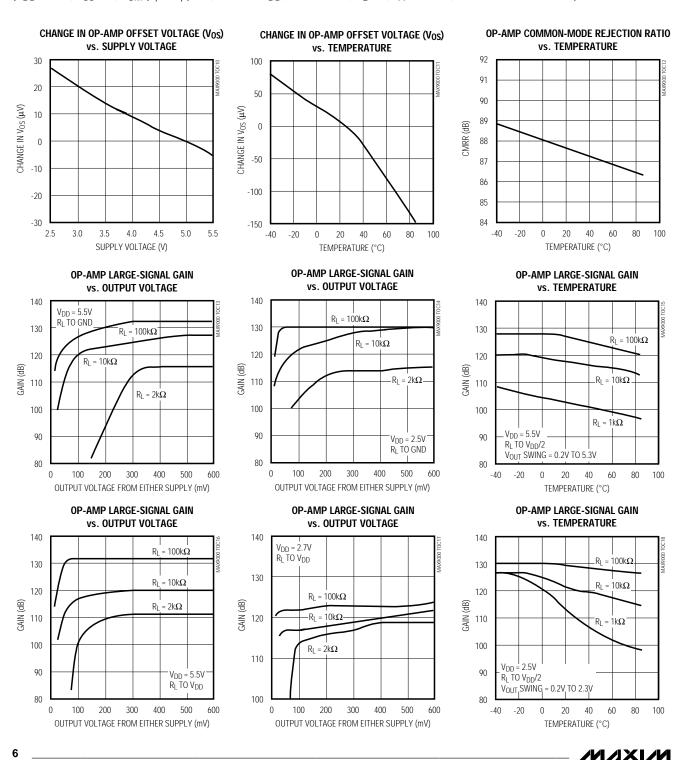
Typical Operating Characteristics

(V_{DD} = +5V, V_{SS} = 0, V_{CM} (op amp) = 0, SHDN = V_{DD}, COUT = low, R_L = ∞ T_A = +25°C, unless otherwise noted.)

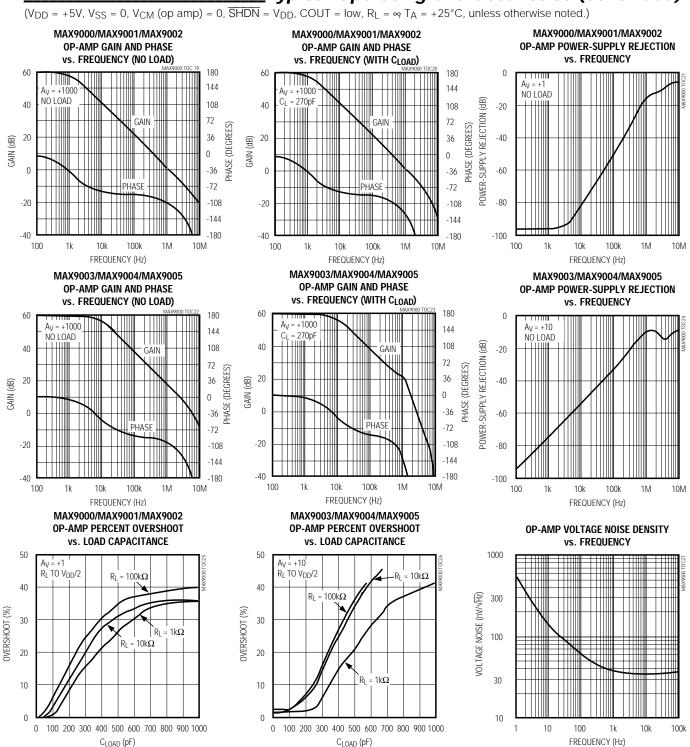


_Typical Operating Characteristics (continued)

(V_{DD} = +5V, V_{SS} = 0, V_{CM} (op amp) = 0, SHDN = V_{DD}, COUT = low, R_L = ∞ T_A = +25°C, unless otherwise noted.)



Typical Operating Characteristics (continued)

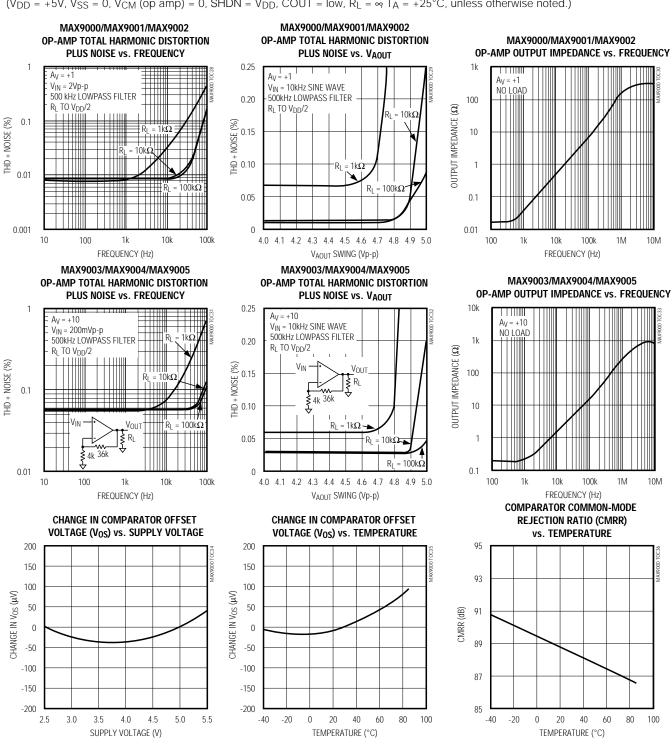


NIXIN



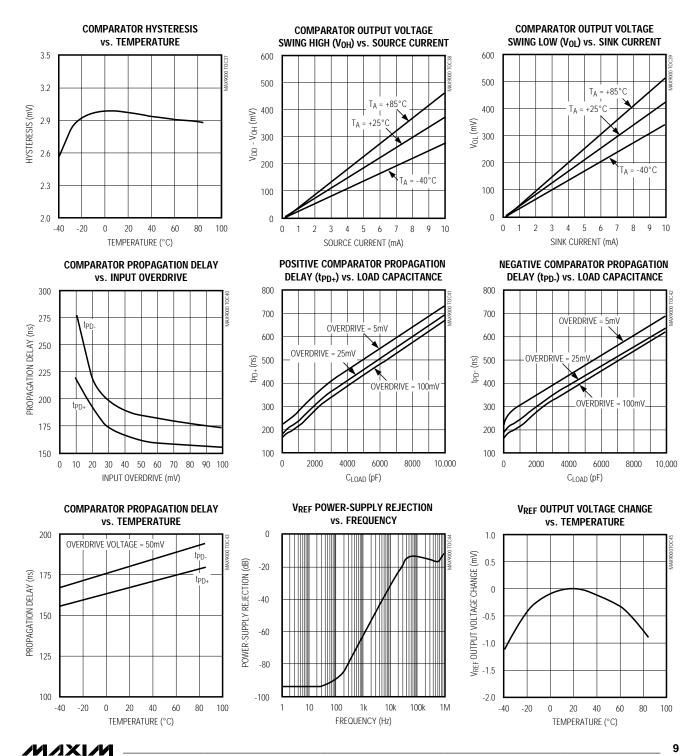
M/IXI/N

(V_{DD} = +5V, V_{SS} = 0, V_{CM} (op amp) = 0, SHDN = V_{DD}, COUT = low, R_L = ∞ T_A = +25°C, unless otherwise noted.)



Typical Operating Characteristics (continued)

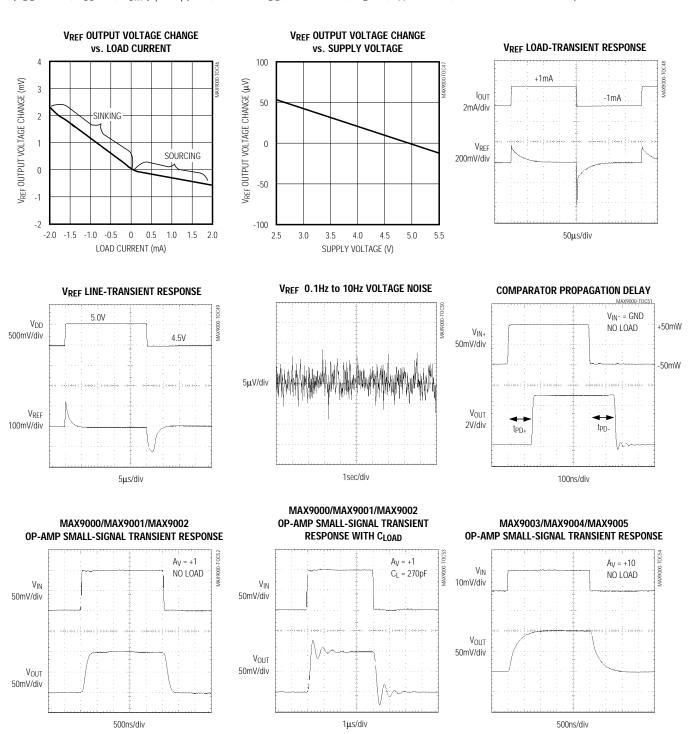
 $(V_{DD} = +5V, V_{SS} = 0, V_{CM} \text{ (op amp)} = 0, \overline{SHDN} = V_{DD}, COUT = low, R_L = \infty T_A = +25^{\circ}C, unless otherwise noted.)$



Typical Operating Characteristics (continued)

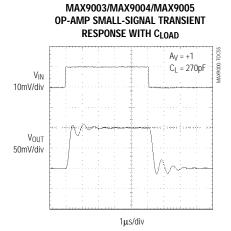
N/IXI/N

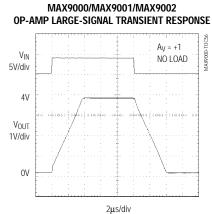
(V_{DD} = +5V, V_{SS} = 0, V_{CM} (op amp) = 0, SHDN = V_{DD}, COUT = low, R_L = ∞ T_A = +25°C, unless otherwise noted.)

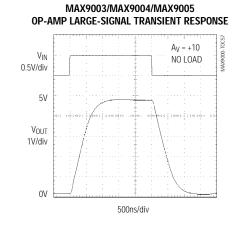


Typical Operating Characteristics (continued)

 $(V_{DD} = +5V, V_{SS} = 0, V_{CM} \text{ (op amp)} = 0, \overline{SHDN} = V_{DD}, COUT = low, R_L = \infty T_A = +25^{\circ}C, unless otherwise noted.)$







Pin Description

	Р	IN			
MAX9000/	MAX9002/	MAX9001	/MAX9004	NAME	FUNCTION
MAX9003	MAX9005	10 μMAX	14 SO		
_	_	1	2	SHDN	Shutdown Logic Input
1	1	2	3	AOUT	Op-Amp Output
2	2	3	4	AIN-	Inverting Op-Amp Input
3	3	4	5	AIN+	Noninverting Op-Amp Input
4	4	5	6	V _{SS}	Negative Supply or Ground
5	_	6	9	REF	Internal Reference Output
_	5	7	10	CIN-	Inverting Comparator Input
6	6	8	11	CIN+	Noninverting Comparator Input
7	7	9	12	COUT	Comparator Output
8	8	10	13	V _{DD}	Positive Supply
_	_	_	1, 7, 8, 14	N.C.	No Connection. Not internally connected.

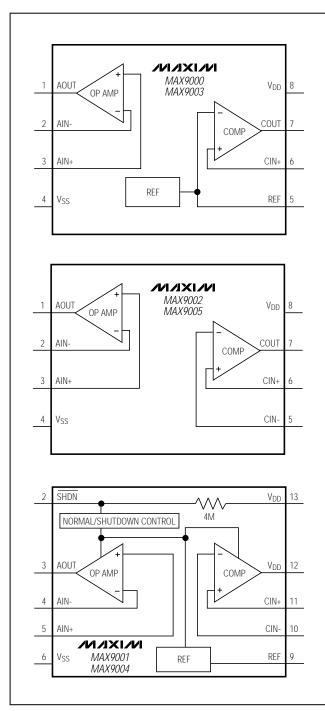


Figure 1. MAX9000-MAX90005 Functional Diagrams

Detailed Description

The MAX9001-MAX9005 are combinations of a highspeed operational amplifier, a 185ns comparator, and a 1%-accurate, 8ppm/°C, 1.230V reference. The devices are offered in space-saving 8-pin and 10-pin µMAX packages. The comparator's inverting input is internally connected to the reference output in the MAX9000/MAX9003. The MAX9002/MAX9005 do not have an internal reference, but the inverting input of the comparator is available externally. The MAX9001/MAX9004 include both the inverting input and the reference output. The MAX9000/ MAX9001/MAX9003/MAX9004 typically consume only 410µA of quiescent current, while the MAX9002/ MAX9004 typically consume 340µA. These low-power, Rail-to-Rail devices provide excellent AC and DC performance and are ideally suited to operate from a single supply. The MAX9001/MAX9004 feature a shutdown mode that sets the outputs in a high-impedance state and reduces the supply current to 2µA, making these devices ideal for portable and battery-powered systems.

Op Amp

The op amps in the MAX9000/MAX9001/MAX9002 are unity-gain stable with a gain-bandwidth product of 1.25MHz and a slew rate of 0.85V/µs. The amplifiers in the MAX9003/MAX9004/MAX9005 are stable at closed-loop gains greater than or equal to 10V/V, with a gain-bandwidth product of 8MHz and a slew rate of 6.0V/µs.

The common-mode input voltage range extends from 150mV below the negative rail to within 1.2V of the positive rail. The amplifier output does not undergo phase reversal when the common-mode input range is exceeded, and the input impedance is relatively constant for input voltages within both supply rails. The MOS differential inputs of the amplifiers feature extremely high input impedance and ultra-low input bias currents. The CMOS output stage achieves true rail-to-rail operation; the outputs swing to within a few millivolts of the supply rails, thus extending the dynamic range. A proprietary design achieves high open-loop gain, enabling these devices to operate at low quiescent currents yet maintain excellent DC and AC characteristics under various load conditions. These devices have been designed to maintain low offset voltage over the entire operating-temperature, commonmode, and supply-voltage ranges.

Comparator

The common-mode input range extends from 150mV below the negative rail to within 1.1V of the positive rail. The bipolar differential inputs of the comparator feature high input impedance and low input bias currents. The comparators are designed to maintain low offset voltage over the entire operating-temperature, common-mode, and supply-voltage ranges. In the MAX9000/MAX9003, the comparator's inverting input is internally connected to the reference output.

The CMOS output stage achieves true rail-to-rail operation; the outputs swing to within a few millivolts of the supply rails. The comparator's propagation delay is 185ns and is a function of the overdrive (see *Typical Operating Characteristics*). TTL/CMOS compatibility is maintained even with a ±4mA output load. A proprietary design of the output stage substantially reduces the cross-conduction current during output transitions, thereby minimizing power-supply glitches typical of most comparators. In addition, the comparator's ±2mV of built-in hysteresis provides noise immunity and prevents unstable outputs even with slow-moving input signals.

Voltage Reference

The 1%-accurate, precision 1.230V internal bandgap reference in the MAX9000/MAX9001/MAX9003/MAX9004 achieves an 8ppm/°C temperature coefficient (tempco). The reference can sink or source 1mA of load current with excellent load regulation. The output typically changes only 60µV for a 3V change in input voltage (line regulation). The reference is stable for capacitive loads up to 100nF.

_Applications Information

The MAX9000–MAX9005 offer excellent performance and low power consumption, and are available in space-saving μ MAX packages. The following section provides some practical application guidelines.

Bypassing and Layout

The MAX9000–MAX9005 operate from a $\pm 2.5 \text{V}$ to $\pm 5.5 \text{V}$ single supply or from $\pm 1.25 \text{V}$ to $\pm 2.75 \text{V}$ dual supplies. (In the MAX9000/MAX9001/MAX9003/MAX9004, the reference voltage is referred to as Vss.). For single-supply operation, bypass the power supply with a 0.1 μ F capacitor. For dual supplies, bypass each supply to ground. Bypass with capacitors as close as possible to the device to minimize lead inductance and noise. Use a low-inductance ground plane if possible. A printed circuit board with a ground plane is recommended. Avoid using wire-wrap boards, breadboards, or IC sockets. For heavy loads at the comparator's and/or

amplifier's output, add a $1\mu F$ to $10\mu F$ power-supply bypass capacitor.

The device has a high degree of isolation between the various blocks. To maintain isolation, careful layout is required. Take special precautions to avoid crossing signal traces, especially from the outputs to the inputs. For sensitive applications, shielding might be required. In addition, stray capacitance may affect the stability and frequency response of the amplifier. Decrease stray capacitance by minimizing lead lengths in the board layout, as well as placing external components as close to the device as possible.

Op-Amp Frequency Stability

Driving large capacitive loads can cause instability in most low-power, rail-to-rail output amplifiers. These amplifiers are stable with capacitive loads up to 250pF in their minimum gain configuration. Stability with higher capacitive loads can be improved by adding an isolation resistor in series with the op-amp output, as shown in Figure 2. This resistor improves the circuit's phase margin by isolating the load capacitor from the amplifier's output. Figures 3 and 4 show the response of the amplifier with and without an isolation resistor, respectively.

The total capacitance at the op amp's inputs (input capacitance + stray capacitance) along with large-value feedback resistors can cause additional poles within the amplifier's bandwidth, thus degrading the phase margin. To compensate for this effect, place a 2pF to 10pF capacitor across the feedback resistor, as shown in Figure 5.

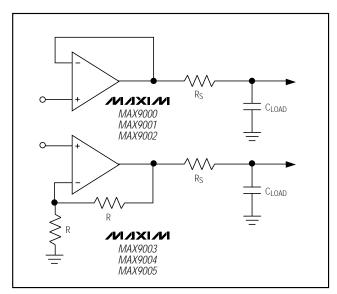


Figure 2. Isolation Resistors to Drive Capacitive Loads

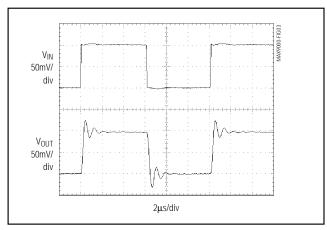


Figure 3. MAX9000/MAX9001/MAX9002 Op-Amp Small-Signal Transient Response with Capacitive Load ($C_L = 510 pF$) and Isolation Resistor ($R_{ISO} = 91 \Omega$)

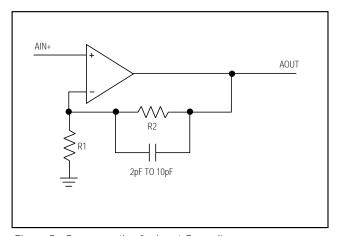


Figure 5. Compensation for Input Capacitance

Reference Bypassing

While the internal reference is stable with capacitive loads up to 100nF, it does not require an output capacitor for stability. However, in applications where the load or the supply could experience large step changes, an output capacitor reduces the amount of overshoot and improves the circuit's transient response.

Comparator Input Stage

The comparator's input bias current is typically 8nA. To reduce the offset error caused by the bias current flowing through the external source impedance, match the effective impedance seen by each input. High source impedance together with the comparator's input capacitance can increase the propagation delay through the

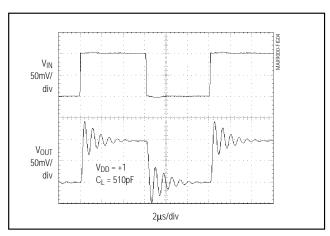


Figure 4. MAX9000/MAX9001/MAX9002 Op-Amp Small-Signal Transient Response with Capacitive Load ($C_L = 510 pF$) and No Isolation Resistor

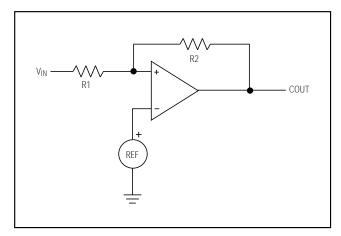


Figure 6. External Hysteresis

comparator. The outputs do not undergo phase reversal when the input common-mode range is exceeded, and the input impedance is relatively constant for input voltages within both supply rails.

Comparator Hysteresis

Built-in ± 2 mV hysteresis improves the comparator's noise immunity. It prevents unstable outputs with slow-moving or noisy input signals. If additional hysteresis is required, add positive feedback as shown in Figure 6. This configuration increases the hysteresis band to desired levels, but also increases power consumption and slows down the output response.

To add hysteresis, use the following procedure:

Step 1: The device's input bias current can be as high as 80nA. To minimize error due to the input bias, choose a value for R2 of $100k\Omega$ (V_{REF} / R2), which allows a current of $12.33\mu A$ at the upper trip point.

Step 2: Choose the width of the hysteresis band. In this example, choose 20mV for the added external hysteresis ($V_{EHYST} = 20mV$). Total hysteresis = $V_{EHYST} + V_{IHYST} = 24mV$.

 $R1 = R2 (V_{EHYST} - 2V_{IHYST}) / (V_{DD} + 2V_{IHYST})$ where IHYST is the device's internal hysteresis.

Step 3: Determine R1. If $V_{DD} = 5V$, then R1 = 319 Ω .

Step 4: Check the hysteresis trip points. The following equation represents the upper trip point $(V_{IN(H)})$:

 $V_{IN(H)} = [(R1 + R2) / R2] (V_{REF} + V_{IHYST}) = 1.238V$ The lower trip point is 24mV lower than upper trip point. $V_{IN(L)} = 1.238V - 0.024V = 1.214V$.

Comparator Propagation Delay

The comparator's propagation delay is a function of the input overdrive voltage. Overdrive voltage is measured from beyond the edge of the offset and hysteresis-determined trip points (see *Typical Operating Characteristics* for a graph of Propagation Delay vs. Input Overdrive). High source impedance coupled with the comparator's input capacitance increases the propagation delay. Large capacitive loads also increase the propagation delay.

Shutdown (SHDN)

Shutdown is active-low enabled. The SHDN input for the MAX9001/MAX9004 can be taken above the posi-

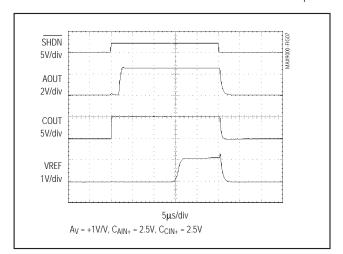


Figure 7. Enable/Disable Response of Op Amp, Comparator, and Reference to SHDN

tive supply without an increase in the \overline{SHDN} input current, allowing them to be driven from independent logic circuits powered from a different supply voltage. However, the logic threshold voltage requirements must be met for proper operation. If \overline{SHDN} is left unconnected, the device defaults to the enabled mode through an internal $4M\Omega$ pull-up to V_{DD} . If \overline{SHDN} is to be left unconnected, take proper care to ensure that no signals are coupled to this pin, as this may cause false triggering.

In shutdown mode, all outputs are set to a high-impedance state and the supply current reduces to $2\mu A$. Enable times for the op amp, comparator, and reference are $2\mu s$, 100ns, and $16\mu s$, respectively. Shutdown delay times for the op amp, comparator, and reference are 200ns, 100ns, and $1\mu s$, respectively (Figure 7).

_Application Circuits

Radio Receiver for Alarms and Detectors

Figure 8's circuit is useful as a front end for RF alarms. An unshielded inductor is used with capacitors C1A, C1B, and C1C in a resonant circuit to provide frequency selectivity. The op amp from a MAX9003 amplifies the signal received. The comparator improves noise immunity, provides a signal-strength threshold, and translates the received signal into a pulse train. The tuned LC circuit in Figure 8 is set for 300kHz. The layout and routing of components for the amplifier should be tight to minimize 60Hz interference and crosstalk from the comparator. Metal shielding is recommended to prevent RFI from the comparator or digital circuitry from exciting the receiving antenna. The transmitting

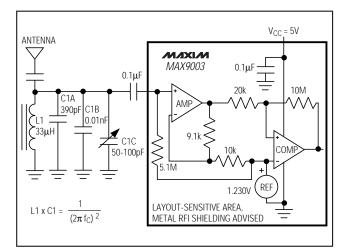


Figure 8. Radio Receiver Application

antenna can be long parallel wires spaced about 7.2cm apart, with equal but opposite currents. Radio waves from this antenna are detectable when the receiver is brought within close proximity, but cancel out at greater distances.

Infrared Receiver Front End for Remote Controls and Data Links

The circuit in Figure 9 uses the MAX9003 as a PIN photodiode preamplifier and discriminator for an infrared receiver. The op amp is configured as a Delyiannisnoise and eliminates low-frequency interference from sunlight, fluorescent lights, etc. This circuit is applicable for TV remote controls and low-frequency data links up to 200kbps. Carrier frequencies are limited to around 100kHz, as in the example circuit. Component layout and routing for the amplifier should be tight to reduce stray capacitance, 60Hz interference, and RFI from the comparator. Crosstalk from comparator edges distorts the amplifier signal. To minimize this effect, add a lowpass RC filter to the connection from the reference to the op amp's noninverting input.

Signal Conditioning

For incoming signals that require filtering, the internal amplifier provides an opportunity to create an active filter. This may be required for relatively high-speed signals that require adequate filtering of high-speed carrier frequencies, harmonics, and external noise. In addition, the amplifier can be used to amplify the signal prior to digitizing it through the comparator to improve the comparator's overall output response and improve its noise immunity.

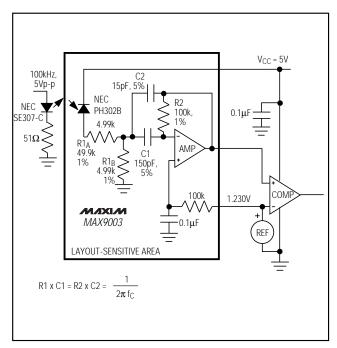
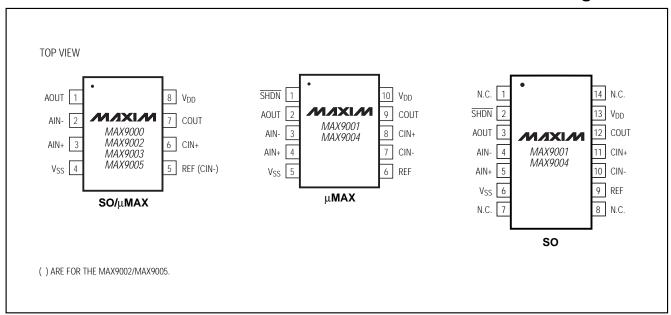


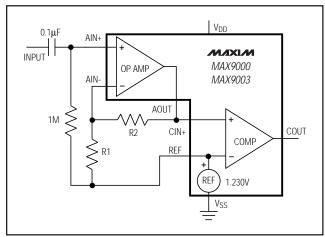
Figure 9. Infrared Receiver Application

___ /N/XI/W

Pin Configurations



Typical Operating Circuit



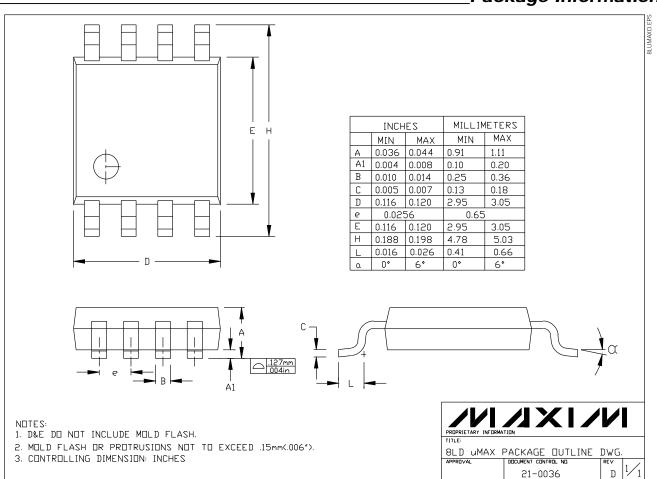
Ordering Information (continued)

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PART	TEMP. RANGE	PIN-PACKAGE
MAX9002EUA	-40°C to +85°C	8 µMAX
MAX9002ESA	-40°C to +85°C	8 SO
MAX9003EUA	-40°C to +85°C	8 µMAX
MAX9003ESA	-40°C to +85°C	8 SO
MAX9004EUB	-40°C to +85°C	10 μMAX
MAX9004ESD	-40°C to +85°C	14 SO
MAX9005EUA	-40°C to +85°C	8 µMAX
MAX9005ESA	-40°C to +85°C	8 SO

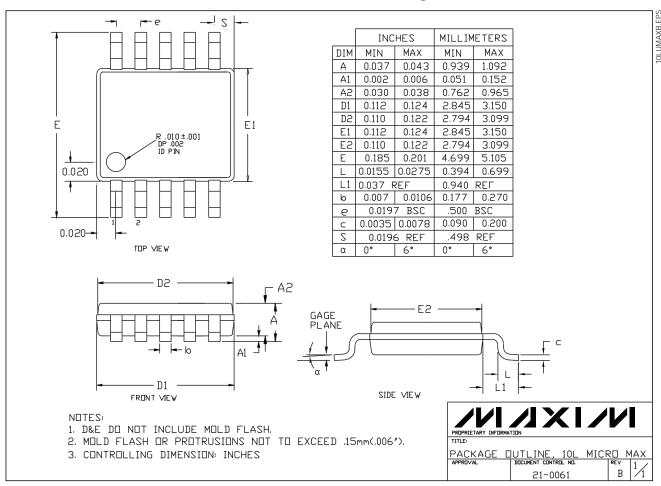
TRANSISTOR COUNT: 283

Package Information



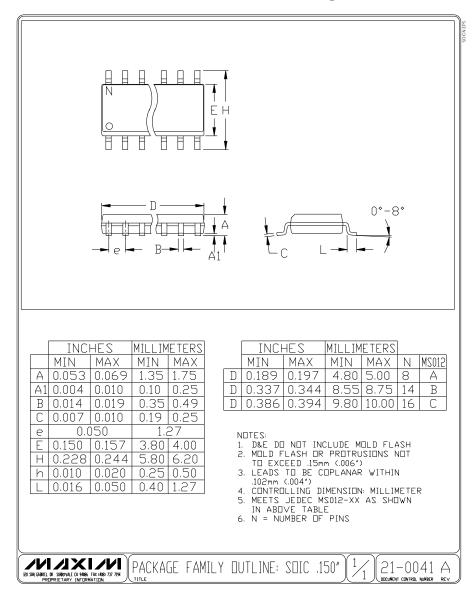
18 ______ **/V**/XI/V

Package Information (continued)



NIXIN

Package Information (continued)



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